


<b>Search Notes</b>  	<b>Application/Control No.</b>  10789778	<b>Applicant(s)/Patent Under Reexamination</b>  SHEHADEH ET AL.
	<b>Examiner</b>  LENA NAJARIAN	<b>Art Unit</b>  3686

SEARCHED			
Class	Subclass	Date	Examiner
705	2, 3	7/1/09	LN

SEARCH NOTES		
Search Notes	Date	Examiner
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	7/1/09	LN
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	7/2/09	LN
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	1/5/10	LN
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	1/6/10	LN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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